

**Search Notes**

Application/Control No.

10/774,306

Examiner

Nick Deichmeister

Applicant(s)/Patent under  
Reexamination

DE JONG ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	229	6/13/2007	NFD
370	235	6/13/2007	NFD
370	236	6/13/2007	NFD
370	328	6/13/2007	NFD
370	329	6/13/2007	NFD
370	349	6/13/2007	NFD

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST search (see attached search history)	6/13/2007	NFD